

# STF16NK60Z STP16NK60Z, STW16NK60Z

N-channel 600 V, 038 Ω 14 A, TO-220, TO-220FP, TO-247 Zener-protected SuperMESH™ Power MOSFET

#### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	Pw
STF16NK60Z	600 V	< 0.42 Ω	14 A <sup>(1)</sup>	40 W
STP16NK60Z	600 V	< 0.42 Ω	14 A	190 W
STW16NK60Z	600 V	< 0.42 Ω	14 A	190 W

- 1. Limited by package.
- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability

### **Application**

Switching applications

## **Description**

The new SuperMESH™ series of Power MOSFETS is the result of further design improvements on ST's well-established strip-based PowerMESH™ layout. In addition to significantly lower on-resistance, the device offers superior dv/dt capability to ensure optimal performance even in the most demanding applications. The SuperMESH™ devices further complement an already broad range of innovative high voltage MOSFETs, which includes the revolutionary MDmesh™ products.

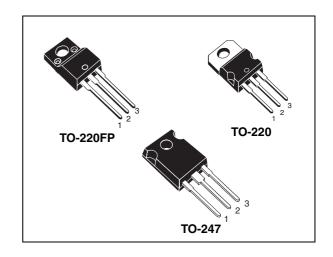


Figure 1. Internal schematic diagram

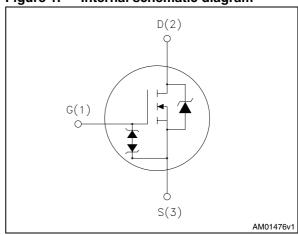


Table 1. Device summary

Order codes	Marking	Package	Packaging
STF16NK60Z	F16NK60Z	TO-220FP	
STP16NK60Z	P16NK60Z	TO-220	Tube
STW16NK60Z	W16NK60Z	TO-247	

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## 1 Electrical ratings

Table 2. Absolute maximum ratings

Complete	Downwarton.	Value		I I m i A
Symbol	Parameter	TO-220 / TO-247	TO-220FP	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	600		V
V <sub>GS</sub>	Gate- source voltage	± 30		V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	14	14 <sup>(1)</sup>	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	8.8	8.8 (1)	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	56 56 <sup>(1)</sup>		Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	190 40		W
	Derating factor	1.51		W/°C
V <sub>ESD(G-S)</sub>	Gate source ESD(HBM-C = 100 pF, R = 1.5 k $\Omega$ )	6000		V
dv/dt (3)	Peak diode recovery voltage slope	4.5		V/ns
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; Tc = 25 °C)	2500		V
T <sub>stg</sub>	Storage temperature	-55 to 150		°C
T <sub>j</sub>	Max. operating junction temperature	150		°C

- 1. Limited by package
- 2. Pulse width limited by safe operating area
- 3.  $I_{SD} \leq$  14 A, di/dt  $\leq$  200 A/ $\mu$ s,  $V_{DD}$  = 80%  $V_{(BR)DSS}$

Table 3. Thermal data

Symbol	Parameter	TO-220	TO-247	TO-220FP	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	nce junction-case max 0.66 3.7		3.1	°C/W
R <sub>thj-amb</sub>	R <sub>thj-amb</sub> Thermal resistance junction-ambient max		50	62.5	°C/W
T <sub>I</sub>	Maximum lead temperature for soldering purpose	300			°C

Table 4. Avalanche characteristics

Symbol Parameter		Max value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)	14	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V)	360	mJ



### 2 Electrical characteristics

 $(T_C = 25 \, ^{\circ}C \text{ unless otherwise specified})$ 

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	620			٧
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max rating $V_{DS}$ = Max rating, $T_{C}$ =125 °C			1 50	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			± 10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 50 \mu A$	3	3.75	4.5	٧
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 7 \text{ A}$		0.38	0.42	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz, V}_{GS} = 0$	-	2650 285 62	-	pF pF pF
C <sub>OSS eq</sub> <sup>(1)</sup>	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0 \text{ to } 480 \text{ V}$	-	158	-	pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 480 \text{ V}, I_{D} = 14 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see <i>Figure 19</i> )	-	86 17 46	-	nC nC nC

C<sub>oss eq</sub>. is defined as a constant equivalent capacitance giving the same charging time as C<sub>oss</sub> when V<sub>D</sub>S increases from 0 to 80% V<sub>DSS</sub>

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
$\begin{array}{c} t_{\rm d(on)} \\ t_{\rm r} \\ t_{\rm d(off)} \\ t_{\rm f} \end{array}$	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 480 \text{ V}, I_{D} = 14 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 18</i> )	-	30 25 70 15	-	ns ns ns ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current Source-drain current (pulsed)		-		14 56	A A
V <sub>SD</sub> (2)	Forward on voltage	I <sub>SD</sub> = 14 A, V <sub>GS</sub> = 0	-		1.6	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> = 14 A, di/dt = 100 A/μs V <sub>DD</sub> = 100 V (see <i>Figure 23</i> )		490 5.4 22		ns nC A
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 14 \text{ A, di/dt} = 100 \text{ A/µs}$ $V_{DD} = 100 \text{ V, T}_j = 150 ^{\circ}\text{C}$ (see <i>Figure 23</i> )	-	585 7 24		ns nC A

- 1. Pulse width limited by safe operating area
- 2. Pulsed: Pulse duration =  $300 \mu s$ , duty cycle 1.5%

Table 9. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
BV <sub>GSO</sub>	Gate-source breakdown voltage	Igs=± 1 mA (open drain)	30	-	-	٧

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

### 2.1 Electrical characteristics (curves)

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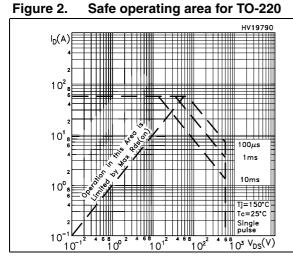


Figure 3. Thermal impedance for TO-220

K  $\delta = 0.5$ 0.2

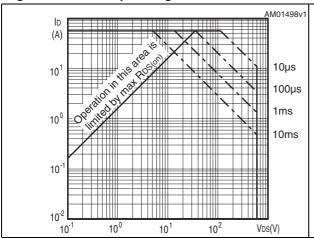
0.1

0.05

0.02  $\lambda_{th} = k R_{thJ-c}$   $\lambda_{th} = k R_{thJ-c}$ 

Figure 4. Safe operating area for TO-220FP

Figure 5. Thermal impedance for TO-220FP



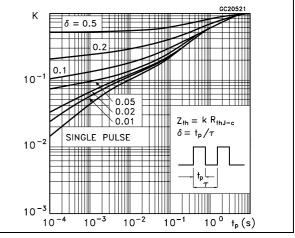
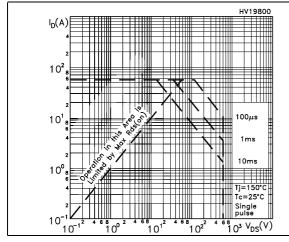


Figure 6. Safe operating area for TO-247

Figure 7. Thermal impedance for TO-247



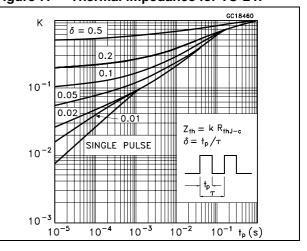


Figure 8. Output characteristics

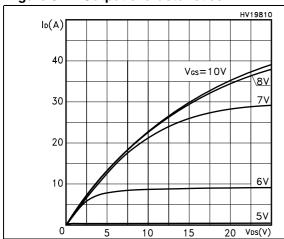


Figure 9. Transfer characteristics

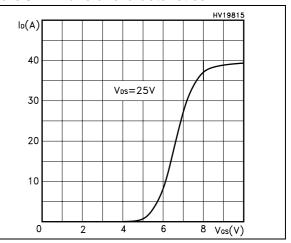
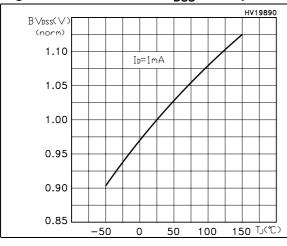


Figure 10. Normalized BV<sub>DSS</sub> vs temperature





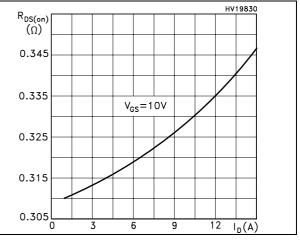
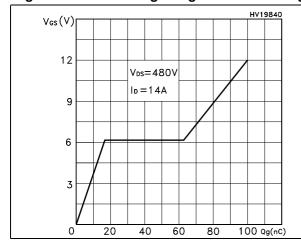
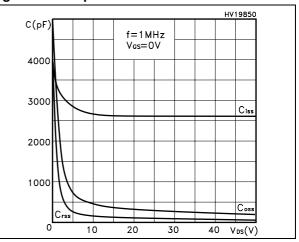


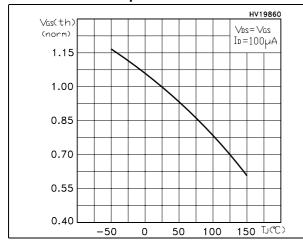
Figure 12. Gate charge vs gate-source voltage Figure 13. Capacitance variations





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Figure 14. Normalized gate threshold voltage Figure 15. Normalized on resistance vs vs temperature temperature



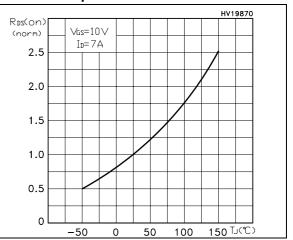
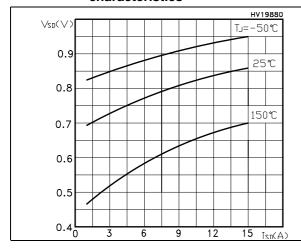
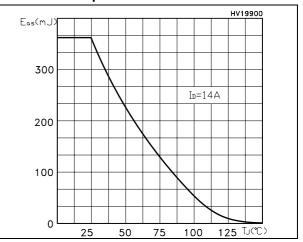


Figure 16. Source-drain diode forward characteristics

Figure 17. Maximum avalanche energy vs temperature





### 3 Test circuits

Figure 18. Switching times test circuit for resistive load

Figure 19. Gate charge test circuit

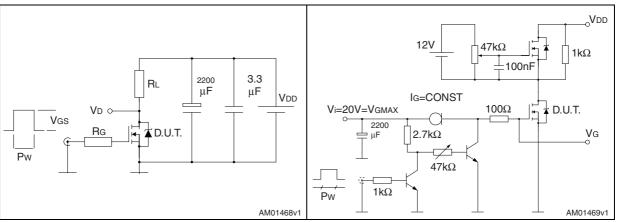


Figure 20. Test circuit for inductive load switching and diode recovery times

Figure 21. Unclamped inductive load test circuit

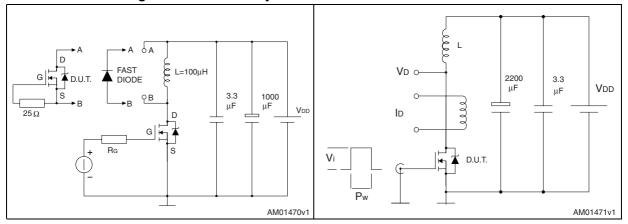
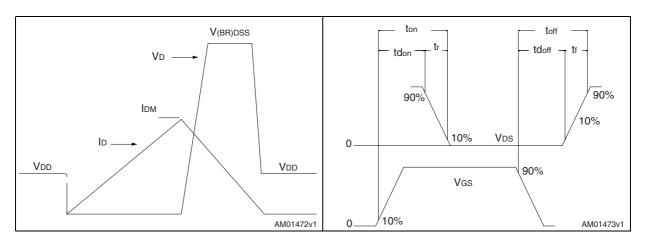


Figure 22. Unclamped inductive waveform

Figure 23. Switching time waveform



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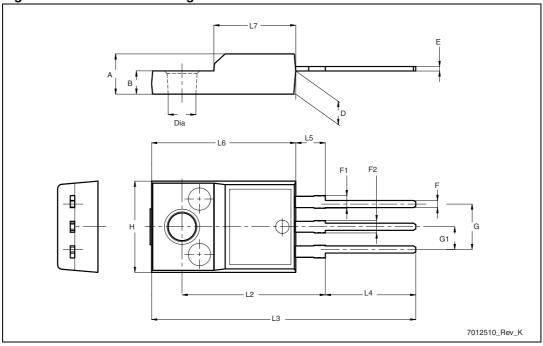
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 10. TO-220FP mechanical data

D:		mm				
Dim.	Min.	Тур.	Max.			
Α	4.4		4.6			
В	2.5		2.7			
D	2.5		2.75			
E	0.45		0.7			
F	0.75		1			
F1	1.15		1.70			
F2	1.15		1.70			
G	4.95		5.2			
G1	2.4		2.7			
Н	10		10.4			
L2		16				
L3	28.6		30.6			
L4	9.8		10.6			
L5	2.9		3.6			
L6	15.9		16.4			
L7	9		9.3			
Dia	3		3.2			

Figure 24. TO-220FP drawing

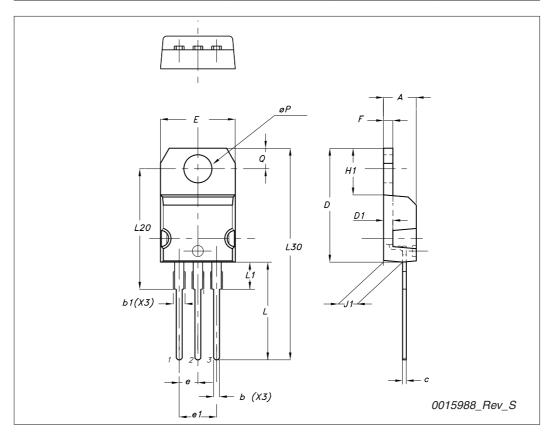


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#### TO-220 type A mechanical data

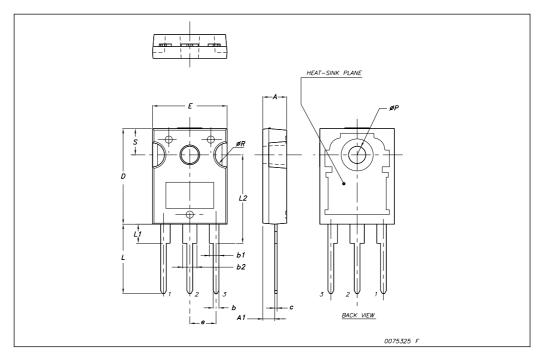
Dim	mm		
	Min	Тур	Max
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95





#### **TO-247 Mechanical data**

Dim.	mm.			
	Min.	Тур	Max.	
Α	4.85		5.15	
A1	2.20		2.60	
b	1.0		1.40	
b1	2.0		2.40	
b2	3.0		3.40	
С	0.40		0.80	
D	19.85		20.15	
Е	15.45		15.75	
е		5.45		
L	14.20		14.80	
L1	3.70		4.30	
L2		18.50		
øΡ	3.55		3.65	
øR	4.50		5.50	
S		5.50		



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# 5 Revision history

Table 11. Document revision history

Date	Revision	Changes
11-Sep-2006	3	
07-Jun-2007	4	Added statement for ECOPACK <sup>®</sup> .
04-Dec-2009	5	Updated packages mechanical data.

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